







SN54LVC02A, SN74LVC02A

#### SCAS280S - JANUARY 1993 - REVISED MAY 2024

# SNx4LVC02A Quadruple 2-Input Positive-NOR Gates

## 1 Features

- Operate from 1.65V to 3.6V
- Specified from -40°C to 85°C, -40°C to 125°C, and -55°C to 125°C
- Inputs accept voltages to 5.5V
- Max t<sub>pd</sub> of 4.4ns at 3.3V
- Typical V<sub>OLP</sub> (output ground bounce) <0.8V at  $V_{CC} = 3.3V$ ,  $T_A = 25^{\circ}C$
- Typical V<sub>OHV</sub> (output V<sub>OH</sub> undershoot) >2V at V<sub>CC</sub> = 3.3V, T<sub>A</sub> = 25°C
- Latch-up performance exceeds 250mA per JESD 17

# 2 Description

Inputs can be driven from either 3.3V or 5V devices. This feature allows the use of these devices as translators in a mixed 3.3V/5V system environment.

The device performs the Boolean function  $Y = \overline{A + B}$ or  $Y = \overline{A} \cdot \overline{B}$  in positive logic.

Inputs can be driven from either 3.3V or 5V devices. This feature allows the use of this device as a translator in a mixed 3.3V/5V system environment.

#### **Device Information**

PART NUMBER	PACKAGE SIZE(1)	PACKAGE SIZE(2)	BODY SIZE(3)
	BQA (WQFN, 14)	3mm × 2.5mm	3mm × 2.5mm
	D (SOIC, 14)	8.65mm × 6mm	8.65mm × 3.9mm
	DB (SSOP, 14)	6.2mm × 7.8mm	6.2mm × 5.3mm
	NS (SOP, 14)	10.2mm × 7.8mm	10.3mm × 5.3mm
SNx4LVC02A	PW (TSSOP, 14)	5mm × 6.4mm	5mm × 4.4mm
	RGY (VQFN, 14)	3.5mm × 3.5mm	3.5mm × 3.5mm
	FK (LCCC, 20)	8.9mm x 8.9mm	8.89mm × 8.89mm
	J (CDIP, 14)	19.55mm x 7.9mm	19.55mm x 6.7mm
	W (CFP, 14)	9.21mm x 9mm	9.21mm x 6.28mm

- For more information, see Section 10.
- (2)The package size (length × width) is a nominal value and includes pins, where applicable.
- The body size (length × width) is a nominal value and does not include pins.



Logic Diagram, Each Gate (Positive Logic)



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# 3 Pin Configuration and Functions

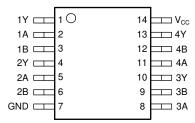


Figure 3-1. SN54LVC02A J or W Package, 14-Pin (Top View)

SN74LVC02A D, DB, NS, or PW Package, 14-Pin SOIC, SSOP, SOP or TSSOP (Top View)

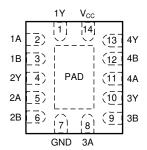


Figure 3-2. SN74LVC02A RGY or BQA Package, 14-Pin VQFN or WQFN (Top View)

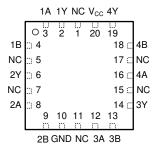


Figure 3-3. SN54LVC02A FK Package, 20-Pin (Top View)

Table 3-1. Pin Functions

	PIN				
	SN74LVC02A	SN54L	VC02A	TYPE <sup>(1)</sup>	DESCRIPTION
NAME	D, DB, NS, PW, RGY, BQA	J, W	FK		DECORAL FICH
1Y	1	1	2	0	1Y Output
1A	2	2	3	I	1A Input
1B	3	3	4	I	1B Input
2Y	4	4	6	0	2Y Output
2A	5	5	8	I	2A Input
2B	6	6	9	I	2B Input
GND	7	7	10	_	Ground Pin
3A	8	8	12	I	3A Input
3B	9	9	13	I	3B Input
3Y	10	20	14	0	3Y Output
4A	11	11	16	I	4A Input
4B	12	12	18	I	4B Input
4Y	13	13	19	0	4Y Output
V <sub>CC</sub>	14	14	20	_	Power Pin
NC	_	_	1, 5, 7, 11, 15, 17	_	No Connection

(1) I = input, O = output



# 4 Specifications

# 4.1 Absolute Maximum Ratings

over operating free-air temperature range (unless otherwise noted)

			MIN	MAX	UNIT
V <sub>CC</sub>	Supply voltage range		-0.5	6.5	V
VI	Input voltage range <sup>(1)</sup>	Input voltage range <sup>(1)</sup>			V
Vo	Output voltage range <sup>(1)</sup> (2)	-0.5	V <sub>CC</sub> + 0.5	V	
I <sub>IK</sub>	Input clamp current	V <sub>I</sub> < 0		-50	mA
I <sub>OK</sub>	Output clamp current	V <sub>O</sub> < 0		-50	mA
Io	Continuous output current			±50	mA
	Continuous current through V <sub>CC</sub> or GND			±100	mA
T <sub>stg</sub>	Storage temperature range		-65	150	°C
P <sub>tot</sub>	Power dissipation	$T_A = -40^{\circ}\text{C to } 125^{\circ}\text{C}^{(3)}$ (4)		500	mW

- (1) The input and output negative-voltage ratings may be exceeded if the input and output current ratings are observed.
- (2) The value of V<sub>CC</sub> is provided in the recommended operating conditions table.
- (3) For the D package: above 70°C, the value of  $P_{tot}$  derates linearly with 8 mW/K.
- (4) For the DB, NS, and PW packages: above 60°C, the value of Ptot derates linearly with 5.5 mW/K.

# 4.2 ESD Ratings

			VALUE	UNIT
V	Electrostatic discharge	Human-body model (HBM), per ANSI/ESDA/JEDEC JS-001 <sup>(1)</sup>	±2000	V
V (ESD)	Lieurostatio discriarge	Charged device model (CDM), per ANSI/ESDA/JEDEC JS-002 <sup>(2)</sup>	±1000	

- (1) JEDEC document JEP155 states that 500-V HBM allows safe manufacturing with a standard ESD control process.
- (2) JEDEC document JEP157 states that 250-V CDM allows safe manufacturing with a standard ESD control process.

## 4.3 Recommended Operating Conditions, SN54LVC02A

			SN54LV	C02A	
			-55°C to	125°C	UNIT
			MIN	MAX	
.,	Cumplicivaltoria	Operating	2	3.6	V
V <sub>CC</sub>	Supply voltage	Data retention only	1.5		V
V <sub>IH</sub>	High-level input voltage	V <sub>CC</sub> = 2.7V to 3.6V	2		V
V <sub>IL</sub>	Low-level input voltage	V <sub>CC</sub> = 2.7V to 3.6V		0.8	V
VI	Input voltage		0	5.5	V
Vo	Output voltage		0	V <sub>CC</sub>	V
	High level output ourrent	V <sub>CC</sub> = 2.7V		-12	A
Іон	High-level output current	V <sub>CC</sub> = 3V		-24	mA
	Low-level output current	V <sub>CC</sub> = 2.7V		12	mA
loL	Low-level output current	V <sub>CC</sub> = 3V		24	IIIA

# 4.4 Recommended Operating Conditions, SN74LVC02A

			T <sub>A</sub> = 25°C -4		–40°C to	-40°C to 85°C		-40°C to 125°C	
			MIN	MAX	MIN	MAX	MIN	MAX	
V Cumply well-	Operating	1.65	3.6	1.65	3.6	1.65	3.6	\/	
V <sub>CC</sub> Supply voltage		Data retention only	1.5		1.5		1.5		V

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					SN74LV0	C02A				
			T <sub>A</sub> = 2	5°C	−40°C to	85°C	−40°C to	125°C	UNIT	
			MIN	MAX	MIN	MAX	MIN	MAX		
.,	High-level	V <sub>CC</sub> = 1.65V to 1.95V	0.65 × V <sub>CC</sub>		0.65 × V <sub>CC</sub>		0.65 × V <sub>CC</sub>		.,	
$V_{IH}$	input voltage	V <sub>CC</sub> = 2.3V to 2.7V	1.7		1.7		1.7		V	
		V <sub>CC</sub> = 2.7V to 3.6V	2		2		2			
	Low-level	V <sub>CC</sub> = 1.65V to 1.95V		0.35 × V <sub>CC</sub>		0.35 × V <sub>CC</sub>		0.35 × V <sub>CC</sub>		
$V_{IL}$	input voltage	V <sub>CC</sub> = 2.3V to 2.7 V		0.7		0.7		0.7	V	
		V <sub>CC</sub> = 2.7V to 3.6 V		0.8		8.0		0.8		
V <sub>I</sub>	Input voltage		0	5.5	0	5.5	0	5.5	V	
Vo	Output voltage		0	V <sub>CC</sub>	0	V <sub>CC</sub>	0	V <sub>CC</sub>	V	
		V <sub>CC</sub> = 1.65V		-4		-4		-4		
	High-level	V <sub>CC</sub> = 2.3V		-8		-8		-8	m Λ	
I <sub>OH</sub>	output current	V <sub>CC</sub> = 2.7V		-12		-12		-12	mA	
		V <sub>CC</sub> = 3V		-24		-24		-24		
		V <sub>CC</sub> = 1.65V		4		4		4		
	Low-level	V <sub>CC</sub> = 2.3V		8		8		8	mA	
I <sub>OL</sub>	output current	V <sub>CC</sub> = 2.7V		12		12		12		
		V <sub>CC</sub> = 3V		24		24		24		

# 4.5 Thermal Information

		SN74LVC02A						
THERMAL METRIC(1)		BQA (WQFN)	D (SOIC)	DB (SSOP)	NS (SOP)	PW (TSSOP)	RGY (VQFN)	UNIT
		14 PINS	14 PINS	14 PINS	14 PINS	14 PINS	14 PINS	
$R_{\theta JA}$	Junction-to-ambient thermal resistance	102.3	86	140.4	123.8	150.8	92.1	°C/W

<sup>(1)</sup> For more information about traditional and new thermal metrics, see the Semiconductor and IC package thermal metrics application report.

# 4.6 Electrical Characteristics, SN54LVC02A

over recommended operating free-air temperature range (unless otherwise noted)

			SN54L		
PARAMETER	TEST CONDITIONS	V <sub>cc</sub>	-55°C 1	UNIT	
			MIN	TYP MA	x
	I <sub>OH</sub> = -100μA	2.7V to 3.6V	V <sub>CC</sub> - 0.2		
	I - 12mA	2.7V	2.2		V
V <sub>OH</sub>	I <sub>OH</sub> = -12mA	3V	2.4		v
	I <sub>OH</sub> = -24mA	3V	2.2	MIN TYP MAX  - 0.2  2.2  2.4	
	I <sub>OL</sub> = 100μA	2.7V to 3.6V		0	2
V <sub>OL</sub>	I <sub>OL</sub> = 12mA	2.7V		0	4 V
	I <sub>OL</sub> = 24mA	3V		0.5	5
I <sub>I</sub>	V <sub>I</sub> = 5.5V or GND	3.6V		±	5 μΑ
I <sub>CC</sub>	$V_I = V_{CC}$ or GND, $I_O = 0$	3.6V		1	0 μΑ
ΔI <sub>CC</sub>	One input at $V_{CC}$ – 0.6V, Other inputs at $V_{CC}$ or GND	2.7V to 3.6V		50	0 μΑ
C <sub>i</sub>	V <sub>I</sub> = V <sub>CC</sub> or GND	3.3V		5 <sup>(1)</sup>	pF

(1)  $T_A = 25^{\circ}C$ 



## 4.7 Electrical Characteristics, SN74LVC02A

over recommended operating free-air temperature range (unless otherwise noted)

	line of oraning in oraning		SN74LVC02A							
PARAMETER	TEST CONDITIONS	V <sub>cc</sub>	T <sub>A</sub> = 25°C			-40°C to 85°C		-40°C to 125°C		UNIT
			MIN	TYP M	AX	MIN	MAX	MIN	MAX	
	I <sub>OH</sub> = -100μA	1.65V to 3.6V	V <sub>CC</sub> - 0.2			V <sub>CC</sub> - 0.2		V <sub>CC</sub> - 0.3		.,
	I <sub>OH</sub> = -4mA	1.65V	1.29			1.2		1.05		
V	I <sub>OH</sub> = -8mA	2.3V	1.9			1.7		1.55		
V <sub>OH</sub>	I = 12m A	2.7V	2.2			2.2		2.05		V
	I <sub>OH</sub> = -12mA	3V	2.4			2.4		2.25		
	I <sub>OH</sub> = -24mA	3V	2.3			2.2		2		
	I <sub>OL</sub> = 100μA	1.65V to 3.6V			0.1		0.2		0.3	
	I <sub>OL</sub> = 4mA	1.65V		0	.24		0.45		0.6	
V <sub>OL</sub>	I <sub>OL</sub> = 8mA	2.3V			0.3		0.7		0.75	V
	I <sub>OL</sub> = 12mA	2.7V			0.4		0.4		0.6	
	I <sub>OL</sub> = 24mA	3V		0	.55		0.55		0.8	
I <sub>I</sub>	V <sub>I</sub> = 5.5V or GND	3.6V			±1		±5		±20	μA
I <sub>CC</sub>	$V_I = V_{CC}$ or GND, $I_O = 0$	3.6V			1		10		40	μA
ΔI <sub>CC</sub>	One input at V <sub>CC</sub> - 0.6 V, Other inputs at V <sub>CC</sub> or GND	2.7V to 3.6V		5	500		500		5000	μΑ
C <sub>i</sub>	V <sub>I</sub> = V <sub>CC</sub> or GND	3.3 V		5						pF

# 4.8 Switching Characteristics, SN54LVC02A

over recommended operating free-air temperature range (unless otherwise noted) (see Load Circuit and Voltage Waveforms)

				SN54LV	UNIT	
PARAMETER	FROM (INPUT)	TO (OUTPUT)	V <sub>cc</sub>	-55°C to 125°C		
	(iiii 53)	(331131)		MIN	MAX	
t <sub>pd</sub> A or B Y	V	2.7V		5.4	no	
	AOIB	ľ	3.3V ± 0.3V	1	4.4	ns

# 4.9 Switching Characteristics, SN74LVC02A

over recommended operating free-air temperature range (unless otherwise noted) (see Load Circuit and Voltage Waveforms)

		TO (OUTPUT)	V <sub>CC</sub>	SN74LVC02A							
PARAMETER FROM (INPUT)	FROM (INPUT)			T <sub>A</sub> = 25°C			-40°C to	85°C	-40°C to	125°C	UNIT
	,		MIN	TYP	MAX	MIN	MAX	MIN	MAX		
		Y	1.8V ± 0.15V	1	3.8	8.4	1	8.9	1	10.4	
	A or B		2.5V ± 0.2V	1	2.9	6.9	1	7.4	1	9.5	
<sup>L</sup> pd	AOIB		2.7V	1	3	5.2	1	5.4	1	7	
		3.3V ± 0.3V	1	3.6	4.2	1	4.4	1	5.5		
t <sub>sk(o)</sub>			3.3V ± 0.3V					1		1.5	ns



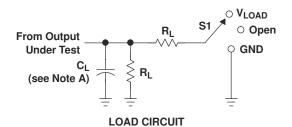
# **4.10 Operating Characteristics**

 $T_A = 25^{\circ}C$ 

	PARAMETER	TEST CONDITIONS	V <sub>cc</sub>	TYP	UNIT
			1.8V	7.5	
$C_{pd}$	Power dissipation capacitance per gate	f = 10MHz	2.5V	8.5	pF
			3.3V	9.5	

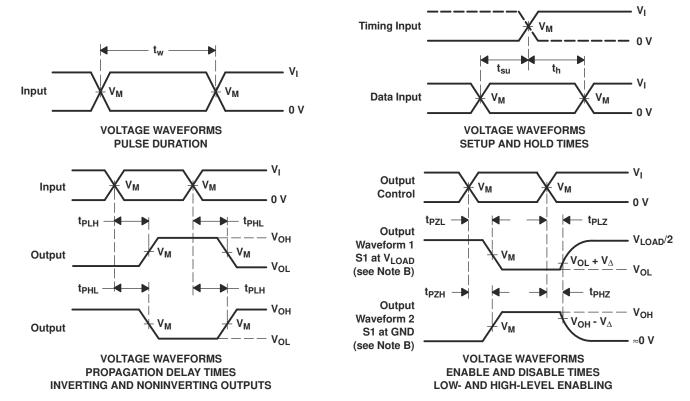


### **5 Parameter Measurement Information**



TEST	S1
t <sub>PLH</sub> /t <sub>PHL</sub>	Open
t <sub>PLZ</sub> /t <sub>PZL</sub>	V <sub>LOAD</sub>
t <sub>PHZ</sub> /t <sub>PZH</sub>	GND

V	INI	PUTS	.,	.,			.,
V <sub>CC</sub>	VI	t <sub>r</sub> /t <sub>f</sub>	V <sub>M</sub>	V <sub>LOAD</sub>	CL	R <sub>L</sub>	$V_\Delta$
1.8 V ± 0.15 V	V <sub>CC</sub>	≤2 ns	V <sub>CC</sub> /2	2×V <sub>CC</sub>	30 pF	<b>1 k</b> Ω	0.15 V
2.5 V $\pm$ 0.2 V	V <sub>CC</sub>	≤2 ns	V <sub>CC</sub> /2	2×V <sub>CC</sub>	30 pF	500 Ω	0.15 V
2.7 V	2.7 V	≤2.5 ns	1.5 V	6 V	50 pF	500 Ω	0.3 V
3.3 V ± 0.3 V	2.7 V	<2.5 ns	1.5 V	6 V	50 pF	<b>500</b> Ω	0.3 V



- NOTES: A. C<sub>I</sub> includes probe and jig capacitance.
  - B. Waveform 1 is for an output with internal conditions such that the output is low, except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high, except when disabled by the output control.
  - C. All input pulses are supplied by generators having the following characteristics: PRR  $\leq$  10 MHz,  $Z_O = 50~\Omega$ .
  - D. The outputs are measured one at a time, with one transition per measurement.
  - E.  $t_{PLZ}$  and  $t_{PHZ}$  are the same as  $t_{dis}$ .
  - F.  $t_{PZL}$  and  $t_{PZH}$  are the same as  $t_{en}$ .
  - G. t<sub>PLH</sub> and t<sub>PHL</sub> are the same as t<sub>pd</sub>.
  - H. All parameters and waveforms are not applicable to all devices.

Figure 5-1. Load Circuit and Voltage Waveforms



# **6 Detailed Description**

# **6.1 Functional Block Diagram**



Figure 6-1. Logic Diagram, Each Gate (Positive Logic)

# **6.2 Device Functional Modes**

Function Table (Each Gate)

INP	INPUTS					
Α	Y					
Н	Х	L				
X	Н	L				
L	L	Н				

# 7 Application and Implementation

#### Note

Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes, as well as validating and testing their design implementation to confirm system functionality.

# 7.1 Power Supply Recommendations

The power supply can be any voltage between the minimum and maximum supply voltage rating located in the *Recommended Operating Conditions*. Each  $V_{CC}$  terminal should have a good bypass capacitor to prevent power disturbance. A 0.1- $\mu$ F capacitor is recommended for this device. It is acceptable to parallel multiple bypass caps to reject different frequencies of noise. The 0.1- $\mu$ F and 1- $\mu$ F capacitors are commonly used in parallel. The bypass capacitor should be installed as close to the power terminal as possible for best results, as shown in given example layout image.

## 7.2 Layout

### 7.2.1 Layout Guidelines

When using multiple-input and multiple-channel logic devices inputs must not ever be left floating. In many cases, functions or parts of functions of digital logic devices are unused; for example, when only two inputs of a triple-input AND gate are used or only 3 of the 4 buffer gates are used. Such unused input pins must not be left unconnected because the undefined voltages at the outside connections result in undefined operational states. All unused inputs of digital logic devices must be connected to a logic high or logic low voltage, as defined by the input voltage specifications, to prevent them from floating. The logic level that must be applied to any particular unused input depends on the function of the device. Generally, the inputs are tied to GND or  $V_{CC}$ , whichever makes more sense for the logic function or is more convenient.

#### 7.2.2 Layout Example

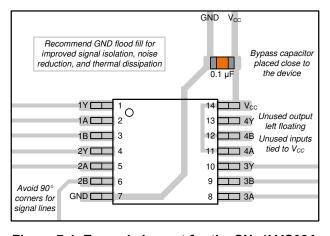


Figure 7-1. Example Layout for the SNx4LVC02A

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# 8 Device and Documentation Support

### 8.1 Documentation Support

#### 8.1.1 Related Documentation

The table below lists quick access links. Categories include technical documents, support and community resources, tools and software, and quick access to sample or buy.

Table 8-1. Related Links

PARTS	PRODUCT FOLDER	SAMPLE & BUY	TECHNICAL DOCUMENTS	TOOLS & SOFTWARE	SUPPORT & COMMUNITY
SN54LVC02A	Click here	Click here	Click here	Click here	Click here
SN74LVC02A	Click here	Click here	Click here	Click here	Click here

#### 8.2 Receiving Notification of Documentation Updates

To receive notification of documentation updates, navigate to the device product folder on ti.com. Click on *Notifications* to register and receive a weekly digest of any product information that has changed. For change details, review the revision history included in any revised document.

# 8.3 Support Resources

TI E2E<sup>™</sup> support forums are an engineer's go-to source for fast, verified answers and design help — straight from the experts. Search existing answers or ask your own question to get the quick design help you need.

Linked content is provided "AS IS" by the respective contributors. They do not constitute TI specifications and do not necessarily reflect TI's views; see TI's Terms of Use.

#### 8.4 Trademarks

TI E2E<sup>™</sup> is a trademark of Texas Instruments.

All trademarks are the property of their respective owners.

#### 8.5 Electrostatic Discharge Caution



This integrated circuit can be damaged by ESD. Texas Instruments recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedures can cause damage.

ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet its published specifications.

#### 8.6 Glossary

TI Glossary

This glossary lists and explains terms, acronyms, and definitions.

#### 9 Revision History

NOTE: Page numbers for previous revisions may differ from page numbers in the current version.

#### Changes from Revision R (March 2024) to Revision S (May 2024)

Page

Updated RθJA values: DB = 96 to 140.4, NS = 76 to 123.8, PW = 113 to 150.8, RGY = 47 to 92.1; Updated DB, NS, PW, and RGY packages for RθJC(top), RθJB, ΨJT, ΨJB, and RθJC(bot), all values in °C/W.............5

#### Changes from Revision Q (July 2005) to Revision R (March 2024)

Page

Added Package Information table, Pin Functions table, ESD Ratings table, Thermal Information table, Device
Functional Modes, Application and Implementation section, Device and Documentation Support section, and
Mechanical, Packaging, and Orderable Information section



Added BQA package to Package Information table, Pin Configuration and Functions section, and Thermal
 Information table

# 10 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.

Product Folder Links: SN54LVC02A SN74LVC02A





www.ti.com 9-Apr-2024

# **PACKAGING INFORMATION**

Orderable Device	Status	Package Type	Package Drawing	Pins	Package Qty	Eco Plan	Lead finish/ Ball material	MSL Peak Temp	Op Temp (°C)	Device Marking (4/5)	Samples
5962-9760401Q2A	ACTIVE	LCCC	FK	20	55	Non-RoHS & Green	SNPB	N / A for Pkg Type	-55 to 125	5962- 9760401Q2A SNJ54LVC 02AFK	Samples
5962-9760401QCA	ACTIVE	CDIP	J	14	25	Non-RoHS & Green	SNPB	N / A for Pkg Type	-55 to 125	5962-9760401QC A SNJ54LVC02AJ	Samples
5962-9760401QDA	ACTIVE	CFP	W	14	25	Non-RoHS & Green	SNPB	N / A for Pkg Type	-55 to 125	5962-9760401QD A SNJ54LVC02AW	Samples
SN74LVC02ABQAR	ACTIVE	WQFN	BQA	14	3000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 125	LVC02A	Samples
SN74LVC02AD	ACTIVE	SOIC	D	14	50	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 125	LVC02A	Samples
SN74LVC02ADBR	ACTIVE	SSOP	DB	14	2000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 125	LC02A	Samples
SN74LVC02ADR	ACTIVE	SOIC	D	14	2500	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 125	LVC02A	Samples
SN74LVC02ADRG4	ACTIVE	SOIC	D	14	2500	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 125	LVC02A	Samples
SN74LVC02ANSR	ACTIVE	SO	NS	14	2000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 125	LVC02A	Samples
SN74LVC02APW	ACTIVE	TSSOP	PW	14	90	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 125	LC02A	Samples
SN74LVC02APWE4	ACTIVE	TSSOP	PW	14	90	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 125	LC02A	Samples
SN74LVC02APWR	ACTIVE	TSSOP	PW	14	2000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 125	LC02A	Samples
SN74LVC02APWT	ACTIVE	TSSOP	PW	14	250	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 125	LC02A	Samples
SN74LVC02ARGYR	ACTIVE	VQFN	RGY	14	3000	RoHS & Green	NIPDAU	Level-2-260C-1 YEAR	-40 to 125	LC02A	Samples
SNJ54LVC02AFK	ACTIVE	LCCC	FK	20	55	Non-RoHS & Green	SNPB	N / A for Pkg Type	-55 to 125	5962- 9760401Q2A SNJ54LVC 02AFK	Samples
SNJ54LVC02AJ	ACTIVE	CDIP	J	14	25	Non-RoHS & Green	SNPB	N / A for Pkg Type	-55 to 125	5962-9760401QC A	Samples

PACKAGE OPTION ADDENDUM

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Orderable Device	Status	Package Type	Package Drawing	Pins	Package Qty	Eco Plan	Lead finish/ Ball material	MSL Peak Temp	Op Temp (°C)	Device Marking (4/5)	Samples
							,			SNJ54LVC02AJ	
SNJ54LVC02AW	ACTIVE	CFP	W	14	25	Non-RoHS & Green	SNPB	N / A for Pkg Type	-55 to 125	5962-9760401QD A SNJ54LVC02AW	Samples

(1) The marketing status values are defined as follows:

**ACTIVE:** Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

**OBSOLETE:** TI has discontinued the production of the device.

(2) RoHS: TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

RoHS Exempt: TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.

Green: TI defines "Green" to mean the content of Chlorine (CI) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.

- (3) MSL, Peak Temp. The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.
- (4) There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.
- (5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.
- (6) Lead finish/Ball material Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

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#### OTHER QUALIFIED VERSIONS OF SN54LVC02A, SN74LVC02A:



# PACKAGE OPTION ADDENDUM

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Automotive: SN74LVC02A-Q1, SN74LVC02A-Q1

● Enhanced Product : SN74LVC02A-EP, SN74LVC02A-EP

Military: SN54LVC02A

#### NOTE: Qualified Version Definitions:

• Catalog - TI's standard catalog product

• Automotive - Q100 devices qualified for high-reliability automotive applications targeting zero defects

• Enhanced Product - Supports Defense, Aerospace and Medical Applications

• Military - QML certified for Military and Defense Applications

# **PACKAGE MATERIALS INFORMATION**

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## TAPE AND REEL INFORMATION





A0	Dimension designed to accommodate the component width
В0	Dimension designed to accommodate the component length
K0	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

#### QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



#### \*All dimensions are nominal

Device	Package Type	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
SN74LVC02ABQAR	WQFN	BQA	14	3000	180.0	12.4	2.8	3.3	1.1	4.0	12.0	Q1
SN74LVC02ADBR	SSOP	DB	14	2000	330.0	16.4	8.35	6.6	2.4	12.0	16.0	Q1
SN74LVC02ADR	SOIC	D	14	2500	330.0	16.4	6.5	9.0	2.1	8.0	16.0	Q1
SN74LVC02ANSR	so	NS	14	2000	330.0	16.4	8.2	10.5	2.5	12.0	16.0	Q1
SN74LVC02APWR	TSSOP	PW	14	2000	330.0	12.4	6.9	5.6	1.6	8.0	12.0	Q1
SN74LVC02APWT	TSSOP	PW	14	250	330.0	12.4	6.9	5.6	1.6	8.0	12.0	Q1
SN74LVC02ARGYR	VQFN	RGY	14	3000	330.0	12.4	3.75	3.75	1.15	8.0	12.0	Q1



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## \*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
SN74LVC02ABQAR	WQFN	BQA	14	3000	210.0	185.0	35.0
SN74LVC02ADBR	SSOP	DB	14	2000	356.0	356.0	35.0
SN74LVC02ADR	SOIC	D	14	2500	356.0	356.0	35.0
SN74LVC02ANSR	SO	NS	14	2000	356.0	356.0	35.0
SN74LVC02APWR	TSSOP	PW	14	2000	356.0	356.0	35.0
SN74LVC02APWT	TSSOP	PW	14	250	356.0	356.0	35.0
SN74LVC02ARGYR	VQFN	RGY	14	3000	356.0	356.0	35.0

# **PACKAGE MATERIALS INFORMATION**

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## **TUBE**



\*All dimensions are nominal

Device	Package Name	Package Type	Pins	SPQ	L (mm)	W (mm)	T (µm)	B (mm)
5962-9760401Q2A	FK	LCCC	20	55	506.98	12.06	2030	NA
5962-9760401QDA	W	CFP	14	25	506.98	26.16	6220	NA
SN74LVC02AD	D	SOIC	14	50	506.6	8	3940	4.32
SN74LVC02APW	PW	TSSOP	14	90	530	10.2	3600	3.5
SN74LVC02APWE4	PW	TSSOP	14	90	530	10.2	3600	3.5
SNJ54LVC02AFK	FK	LCCC	20	55	506.98	12.06	2030	NA
SNJ54LVC02AW	W	CFP	14	25	506.98	26.16	6220	NA

# W (R-GDFP-F14)

# CERAMIC DUAL FLATPACK



- A. All linear dimensions are in inches (millimeters).
- B. This drawing is subject to change without notice.
- C. This package can be hermetically sealed with a ceramic lid using glass frit.
- D. Index point is provided on cap for terminal identification only.
- E. Falls within MIL STD 1835 GDFP1-F14







- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.

  2. This drawing is subject to change without notice.

  3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not
- exceed 0.15 mm per side.
  4. Reference JEDEC registration MO-150.





NOTES: (continued)

- 5. Publication IPC-7351 may have alternate designs.
- 6. Solder mask tolerances between and around signal pads can vary based on board fabrication site.





NOTES: (continued)

- 7. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
- 8. Board assembly site may have different recommendations for stencil design.



8.89 x 8.89, 1.27 mm pitch

LEADLESS CERAMIC CHIP CARRIER

This image is a representation of the package family, actual package may vary. Refer to the product data sheet for package details.



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CERAMIC DUAL IN LINE PACKAGE



Images above are just a representation of the package family, actual package may vary. Refer to the product data sheet for package details.

4040083-5/G





CERAMIC DUAL IN LINE PACKAGE



- 1. All controlling linear dimensions are in inches. Dimensions in brackets are in millimeters. Any dimension in brackets or parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
- 2. This drawing is subject to change without notice.
- 3. This package is hermitically sealed with a ceramic lid using glass frit.
- His package is remitted by sealed with a ceramic its using glass mit.
   Index point is provided on cap for terminal identification only and on press ceramic glass frit seal only.
   Falls within MIL-STD-1835 and GDIP1-T14.



CERAMIC DUAL IN LINE PACKAGE







- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.

  2. This drawing is subject to change without notice.

  3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not
- exceed 0.15 mm per side.
- 4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.25 mm per side.
- 5. Reference JEDEC registration MO-153.





NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.

7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.





NOTES: (continued)

- 8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
- 9. Board assembly site may have different recommendations for stencil design.





SMALL OUTLINE INTEGRATED CIRCUIT



- 1. All linear dimensions are in millimeters. Dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.

  2. This drawing is subject to change without notice.

  3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not
- exceed 0.15 mm, per side.
- 4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.43 mm, per side.
- 5. Reference JEDEC registration MS-012, variation AB.



SMALL OUTLINE INTEGRATED CIRCUIT



NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.

7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.



SMALL OUTLINE INTEGRATED CIRCUIT



NOTES: (continued)

- 8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
- 9. Board assembly site may have different recommendations for stencil design.





NOTES: A. All linear dimensions are in millimeters. Dimensioning and tolerancing per ASME Y14.5M-1994.

- B. This drawing is subject to change without notice.
- C. QFN (Quad Flatpack No-Lead) package configuration.
- D. The package thermal pad must be soldered to the board for thermal and mechanical performance.
- E. See the additional figure in the Product Data Sheet for details regarding the exposed thermal pad features and dimensions.
- Pin 1 identifiers are located on both top and bottom of the package and within the zone indicated. The Pin 1 identifiers are either a molded, marked, or metal feature.
- G. Package complies to JEDEC MO-241 variation BA.



# RGY (S-PVQFN-N14)

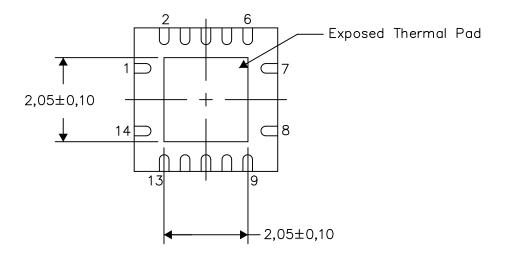
# PLASTIC QUAD FLATPACK NO-LEAD

#### THERMAL INFORMATION

This package incorporates an exposed thermal pad that is designed to be attached directly to an external heatsink. The thermal pad must be soldered directly to the printed circuit board (PCB). After soldering, the PCB can be used as a heatsink. In addition, through the use of thermal vias, the thermal pad can be attached directly to the appropriate copper plane shown in the electrical schematic for the device, or alternatively, can be attached to a special heatsink structure designed into the PCB. This design optimizes the heat transfer from the integrated circuit (IC).

For information on the Quad Flatpack No—Lead (QFN) package and its advantages, refer to Application Report, QFN/SON PCB Attachment, Texas Instruments Literature No. SLUA271. This document is available at www.ti.com.

The exposed thermal pad dimensions for this package are shown in the following illustration.



Bottom View

Exposed Thermal Pad Dimensions

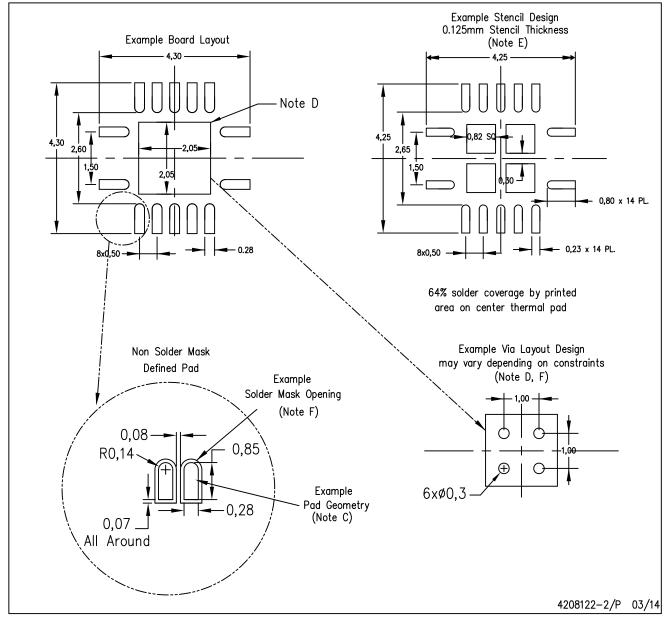
4206353-2/P 03/14

NOTE: All linear dimensions are in millimeters



# RGY (S-PVQFN-N14)

# PLASTIC QUAD FLATPACK NO-LEAD



- A. All linear dimensions are in millimeters.
- B. This drawing is subject to change without notice.
- C. Publication IPC-7351 is recommended for alternate designs.
- D. This package is designed to be soldered to a thermal pad on the board. Refer to Application Note, Quad Flat—Pack QFN/SON PCB Attachment, Texas Instruments Literature No. SLUA271, and also the Product Data Sheets for specific thermal information, via requirements, and recommended board layout. These documents are available at www.ti.com <a href="https://www.ti.com">http://www.ti.com</a>.
- E. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Refer to IPC 7525 for stencil design considerations.
- F. Customers should contact their board fabrication site for minimum solder mask web tolerances between signal pads.



2.5 x 3, 0.5 mm pitch

PLASTIC QUAD FLATPACK - NO LEAD

This image is a representation of the package family, actual package may vary. Refer to the product data sheet for package details.



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PLASTIC QUAD FLAT PACK-NO LEAD



- All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
- 2. This drawing is subject to change without notice.
- 3. The package thermal pad must be soldered to the printed circuit board for optimal thermal and mechanical performance.



PLASTIC QUAD FLAT PACK-NO LEAD



NOTES: (continued)

- 4. This package is designed to be soldered to a thermal pad on the board. For more information, see Texas Instruments literature number SLUA271 (www.ti.com/lit/slua271).
- 5. Vias are optional depending on application, refer to device data sheet. If any vias are implemented, refer to their locations shown on this view. It is recommended that vias under paste be filled, plugged or tented.



PLASTIC QUAD FLAT PACK-NO LEAD



NOTES: (continued)

6. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.



# **MECHANICAL DATA**

# NS (R-PDSO-G\*\*)

# 14-PINS SHOWN

## PLASTIC SMALL-OUTLINE PACKAGE



- A. All linear dimensions are in millimeters.
- B. This drawing is subject to change without notice.
- C. Body dimensions do not include mold flash or protrusion, not to exceed 0,15.



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